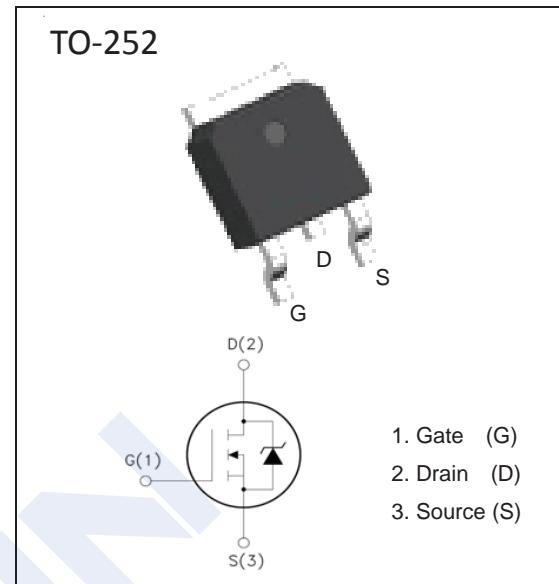


N-Channel MOSFET

2KK5116

■ Features

- $V_{DSS} = 100V$
- $I_D = 33A$
- $R_{DS(ON)} = 19.5m\Omega$ (typ.) @ $V_{GS}=10V$
- $R_{DS(ON)} = 20.5m\Omega$ (typ.) @ $V_{GS}=4.5V$
- Avalanche
- Reliable

■ Absolute Maximum Ratings ($T_c=25^\circ C$ Unless Otherwise Noted)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current $T_c = 25^\circ C$	I_D	33	A
		22	
		130	
Pulsed Drain Current (Note 1)	I_{DM}	190	mJ
Single Pulse Avalanche Energy (Note 2)	E_{AS}	190	mJ
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	110	$^\circ C/W$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	2.3	
Maximum Power Dissipation $T_c = 25^\circ C$	P_D	54	W
		21.7	
Operating Junction and Storage Temperature Range	T_J, T_{Stg}	-55 to 150	$^\circ C$

Notes

1. Repetitive rating ; pulse width limited by junction temperature.
2. $L = 0.5mH$, $V_D=80V$.

2KK5116

■ Electrical Characteristics ($T_c=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	100			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=100\text{V}, V_{GS}=0\text{V}$		1		μA
		$V_{DS}=100\text{V}, V_{GS}=0\text{V}, T_J=85^\circ\text{C}$		30		
Gate-Body Leakage Current	I_{GSS}	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$		± 100		nA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.0		3.0	V
Static Drain-Source On-Resistance (Note 1)	$R_{DS(\text{ON})}$	$V_{GS}=10\text{V}, I_D=16\text{A}$		19.5	24	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=16\text{A}$		20.5	26	
Gate Resistance	R_G	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		1.2		Ω
Input Capacitance	C_{iss}	$V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1\text{MHz}$		3900		pF
Output Capacitance	C_{oss}			115		
Reverse Transfer Capacitance	C_{rss}			102		
Turn-On Delay Time	$t_{d(on)}$	$V_{DD}=50\text{V}, I_D=16\text{A}, R_G=3\Omega, V_{GS}=10\text{V}$ (Note 2)		36		ns
Turn-On Rise Time	t_r			15		
Turn-Off Delay Time	$t_{d(off)}$			79		
Turn-Off Fall Time	t_f			20		
Total Gate Charge	Q_g	$V_{DS}=80\text{V}, I_D=16\text{A}, V_{GS}=10\text{V}$		90		nC
Gate Source Charge	Q_{gs}			10		
Gate Drain Charge	Q_{gd}			19		
Body Diode Voltage (Note 1)	V_{SD}	$I_S=16\text{A}, V_{GS}=0\text{V}$		0.8	1.3	V
Diode Forward Current	I_S				33	A
Body Diode Reverse Recovery Time	t_{rr}	$V_{GS}=0\text{V}, I_S = 16 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}$		40		ns
Body Diode Reverse Recovery Charge	Q_{rr}			75		

Notes:

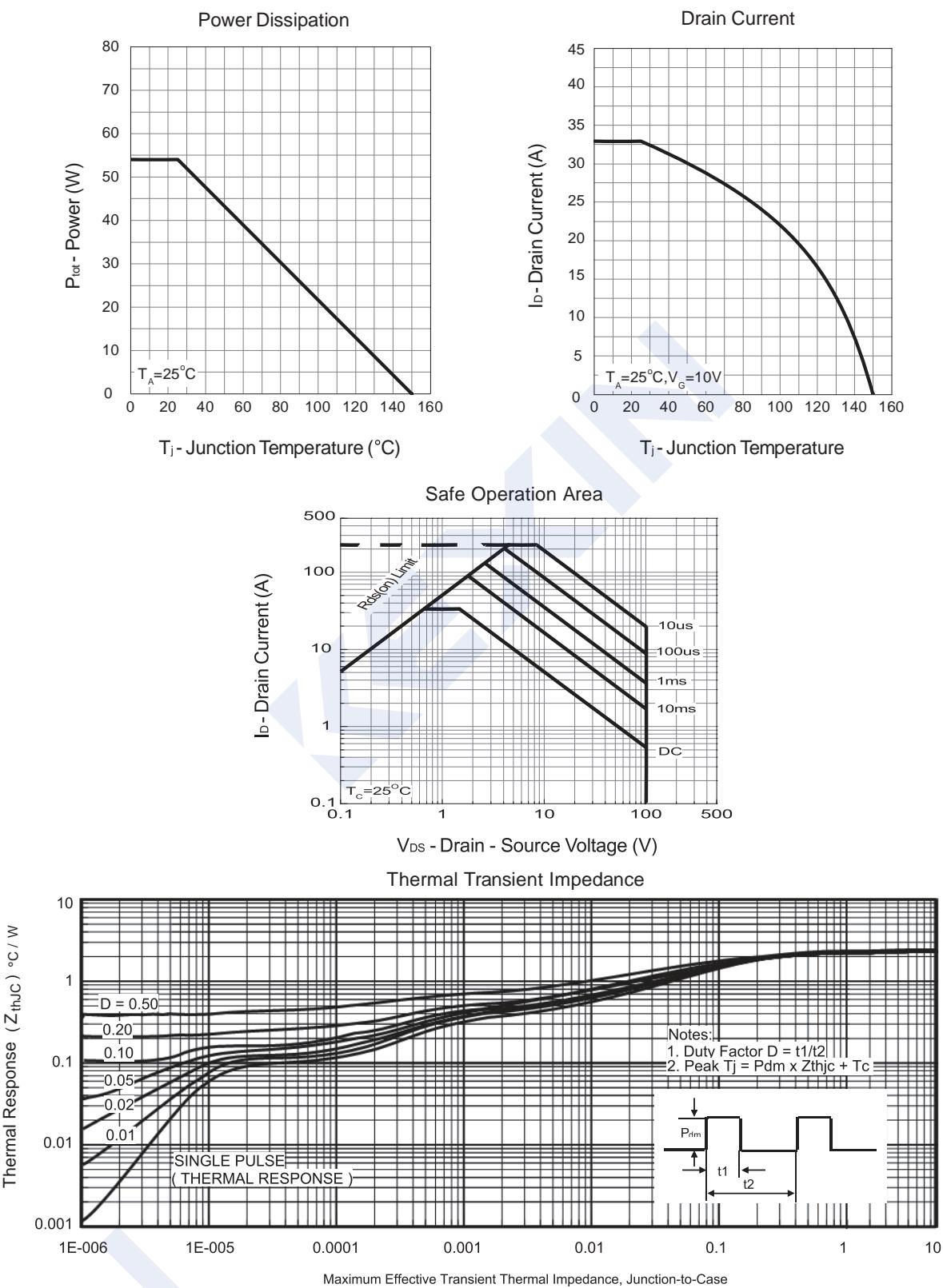
1. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
2. Switching characteristics are independent of operating junction temperature.

■ Marking

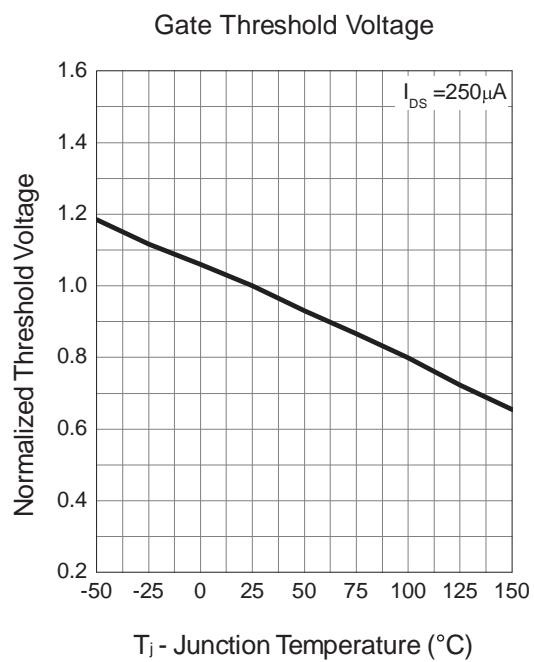
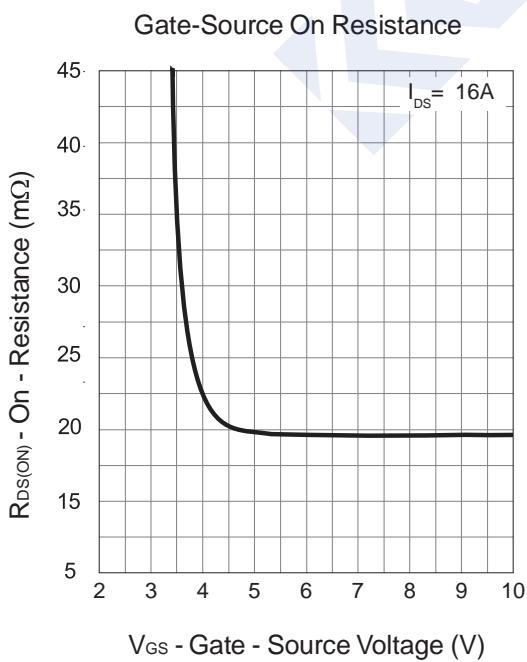
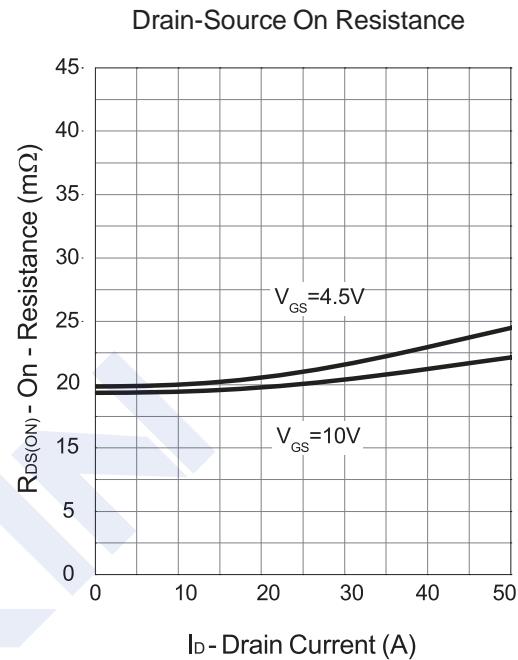
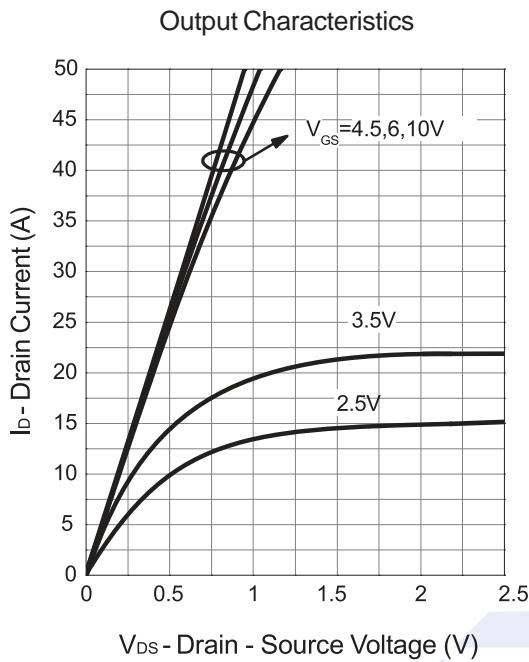
Marking	K5116 K****
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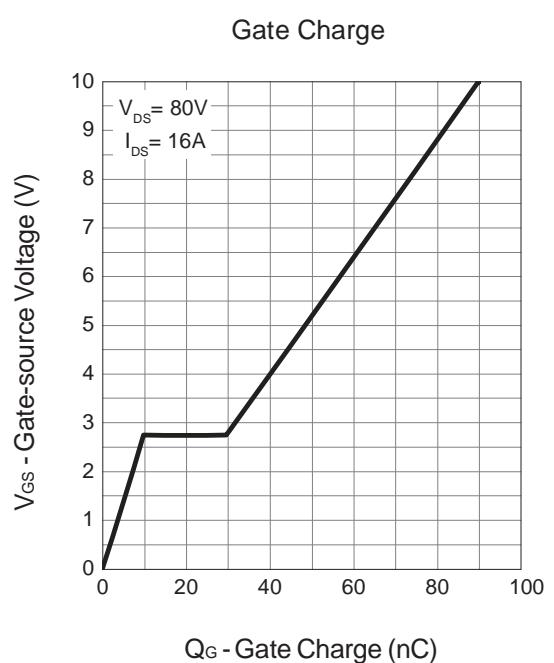
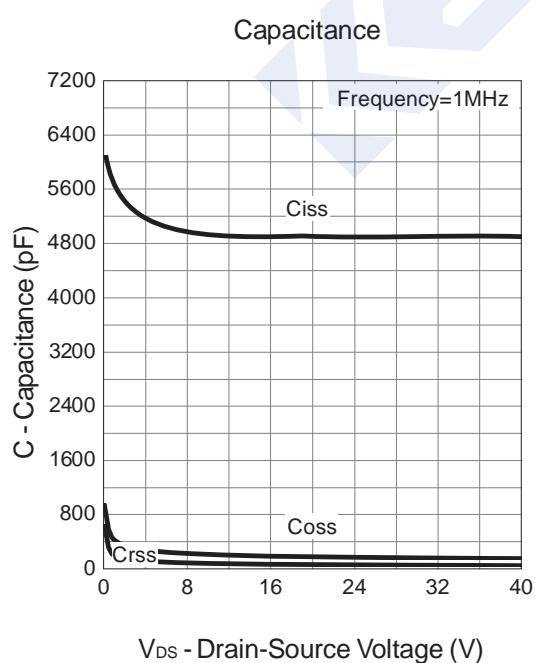
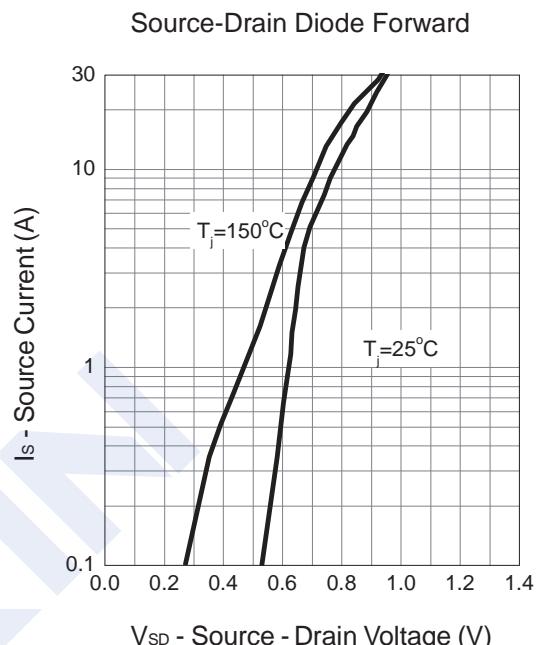
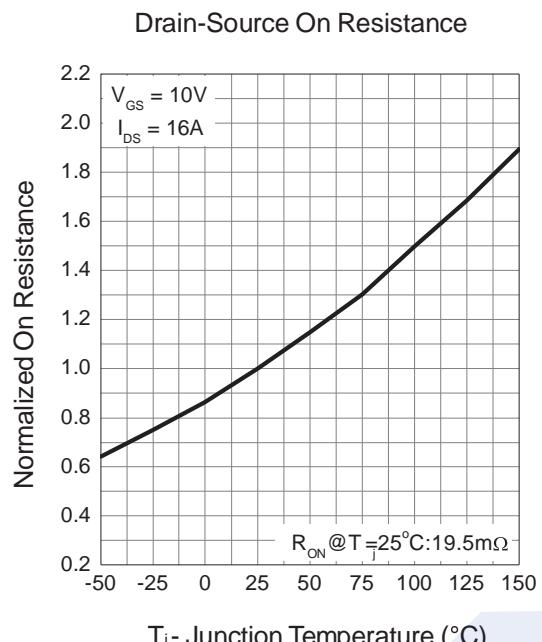
■ Typical Characteristics



2KK5116



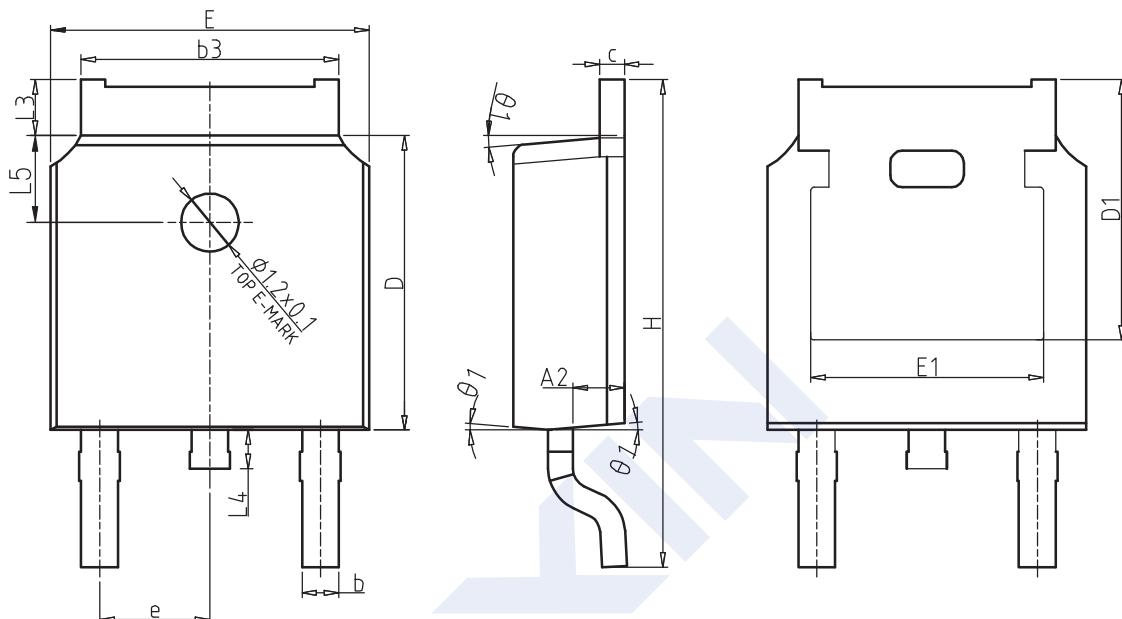
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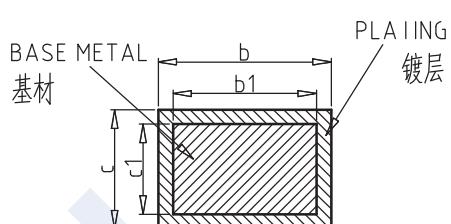
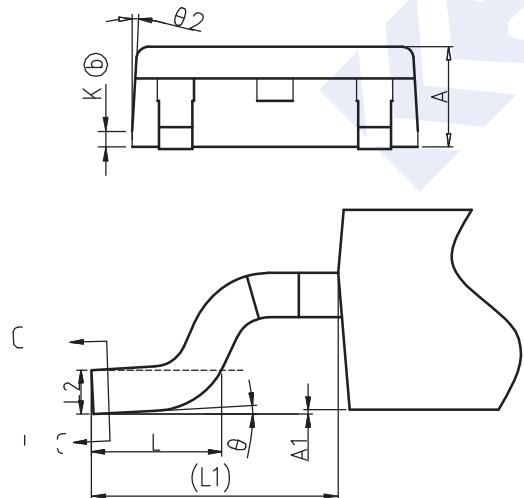
2KK5116

■ Package Dimension

TO-252



COMMON DIMENSIONS



SYMBOL	mm		
	MIN	NOM	MAX
A	2.20	2.30	2.38
A1	0.00	-	0.10
A2	0.97	1.07	1.17
b	0.72	0.78	0.85
b1	0.71	0.76	0.81
b3	5.23	5.33	5.46
c	0.47	0.53	0.58
c1	0.46	0.51	0.56
D	6.00	6.10	6.20
D1		5.30REF	
E	6.50	6.60	6.70
E1	4.70	4.83	4.92
e		2.286BSC	
H	9.90	10.10	10.30
L	1.40	1.50	1.70
L1		2.90REF	
L2		0.51BSC	
L3	0.90	-	1.25
L4	0.60	0.80	1.00
L5	1.70	1.80	1.90
θ	0°	-	8°
θ1	5°	7°	9°
θ2	5°	7°	9°
K		0.40REF	